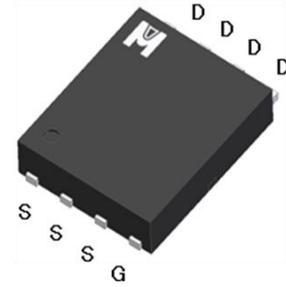
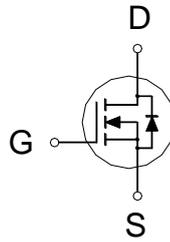


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

| | |
|---------------------|----------------|
| BV_{DSS} | 30V |
| $R_{DS(on)}$ (MAX.) | 11.5m Ω |
| I_D | 25A |



UIS, R_g 100% Tested

RoHS & Halogen Free & TSCA Compliant



ABSOLUTE MAXIMUM RATINGS (T_c = 25 °C Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS | | SYMBOL | LIMITS | UNIT |
|------------------------------------------------|-------------------------------------------------------------|-----------------------------------|------------|------|
| Gate-Source Voltage | | V _{GS} | ±20 | V |
| Continuous Drain Current | T _c = 25 °C | I _D | 25 | A |
| | T _c = 100 °C | | 20 | |
| Pulsed Drain Current ¹ | | I _{DM} | 100 | |
| Avalanche Current | | I _{AS} | 30 | |
| Avalanche Energy | L = 0.1mH, I _D =30A, R _G =25 Ω | E _{AS} | 45 | mJ |
| Repetitive Avalanche Energy ² | L = 0.05mH | E _{AR} | 22.5 | |
| Power Dissipation | T _c = 25 °C | P _D | 35 | W |
| | T _c = 100 °C | | 14 | |
| Operating Junction & Storage Temperature Range | | T _J , T _{stg} | -55 to 150 | °C |

100% UIS testing in condition of V_D=30V, L=0.1mH, V_G=10V, I_L=18A, Rated V_{DS}=30V N-CH

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE | SYMBOL | TYPICAL | MAXIMUM | UNIT |
|----------------------------------|------------------|---------|---------|--------|
| Junction-to-Case | R _{θJC} | | 3.5 | °C / W |
| Junction-to-Ambient ³ | R _{θJA} | | 62 | |

¹Pulse width limited by maximum junction temperature.

²Duty cycle < 1%

³The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz.

Copper, in a still air environment with T_A =25°C.

⁴Guarantee by Engineering test



ELECTRICAL CHARACTERISTICS (T_c = 25 °C, Unless Otherwise Noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | LIMITS | | | UNIT |
|-------------------------------------------------------------------------------|----------------------------------------|-----------------------------------------------------------------------|-------------------------------------------------------------------------------------------|------|------|------|
| | | | MIN | TYP | MAX | |
| STATIC | | | | | | |
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0V, I _D = 250μA | 30 | | | V |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250μA | 1 | 1.7 | 3 | |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0V, V _{GS} = ±20V | | | ±100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 24V, V _{GS} = 0V | | | 1 | μA |
| | | V _{DS} = 20V, V _{GS} = 0V, T _J = 125 °C | | | 25 | |
| On-State Drain Current ¹ | I _{D(ON)} | V _{DS} = 5V, V _{GS} = 10V | 25 | | | A |
| Drain-Source On-State Resistance ¹ | R _{DS(ON)} | V _{GS} = 10V, I _D = 15A | | 9.7 | 11.5 | mΩ |
| | | V _{GS} = 4.5V, I _D = 10A | | 13 | 16 | |
| Forward Transconductance ¹ | g _{fs} | V _{DS} = 5V, I _D = 15A | | 15 | | S |
| DYNAMIC | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0V, V _{DS} = 15V, f = 1MHz | | 1050 | | pF |
| Output Capacitance | C _{oss} | | | 141 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 87 | | |
| Gate Resistance | R _g | V _{GS} = 15mV, V _{DS} = 0V, f = 1MHz | | 1.2 | | Ω |
| Total Gate Charge ^{1,2} | Q _g (V _{GS} =10V) | V _{DS} = 15V, V _{GS} = 10V, I _D = 15A | | 17.6 | | nC |
| | Q _g (V _{GS} =4.5V) | | | 9.0 | | |
| Gate-Source Charge ^{1,2} | Q _{gs} | | | 2.6 | | |
| Gate-Drain Charge ^{1,2} | Q _{gd} | | | 4.0 | | |
| Turn-On Delay Time ^{1,2} | t _{d(on)} | | V _{DS} = 15V, I _D = 5A, V _{GS} = 10V, R _G = 3Ω | | 8 | |
| Rise Time ^{1,2} | t _r | | | 8 | | |
| Turn-Off Delay Time ^{1,2} | t _{d(off)} | | | 15 | | |
| Fall Time ^{1,2} | t _f | | | 10 | | |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T_c = 25 °C) | | | | | | |
| Continuous Current | I _S | | | | 25 | A |
| Pulsed Current ³ | I _{SM} | | | | 100 | |
| Forward Voltage ¹ | V _{SD} | I _F = I _S , V _{GS} = 0V | | | 1.3 | V |
| Reverse Recovery Time | t _{rr} | I _F = I _S , dI _F /dt = 100A / μS | | 18 | | nS |
| Peak Reverse Recovery Current | I _{RM(REC)} | | | 100 | | A |
| Reverse Recovery Charge | Q _{rr} | | | 10 | | nC |



¹Pulse test : Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: EMB12N03HR for EDFN 5 x 6



→ B12N03R: Device Name

→ ABCDEFG: Date Code

A: Assembly House

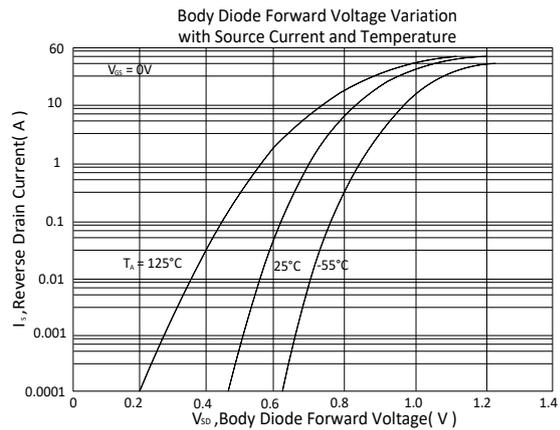
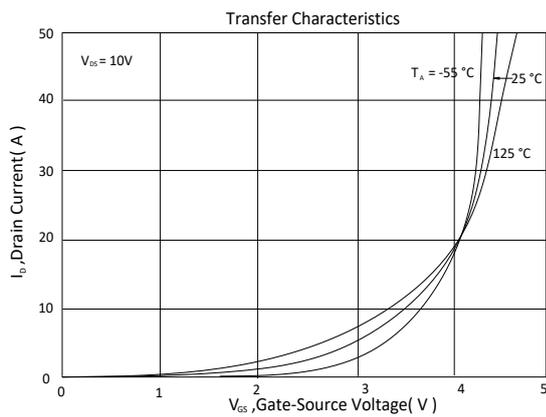
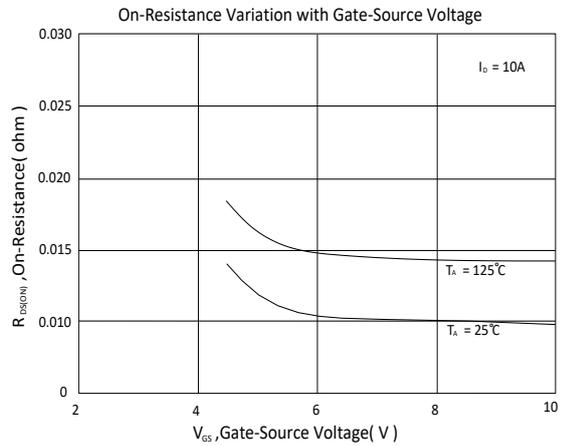
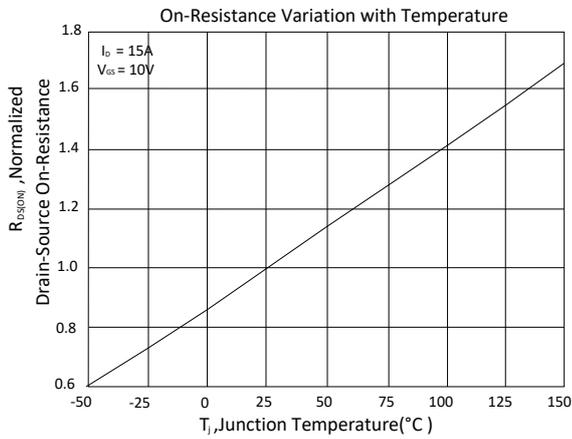
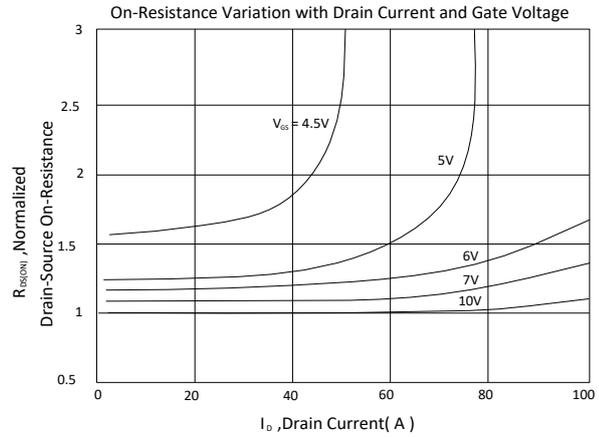
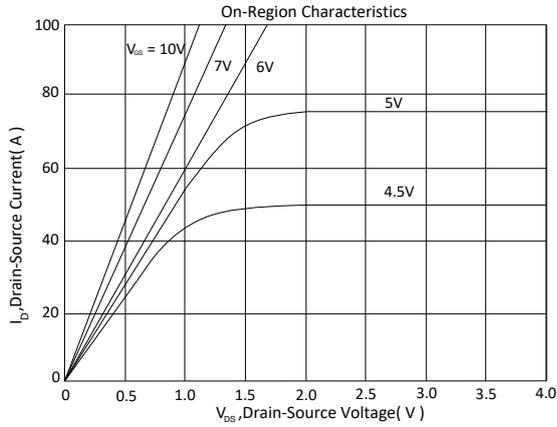
B: Year(A:2008 B:2009 C:2010....)

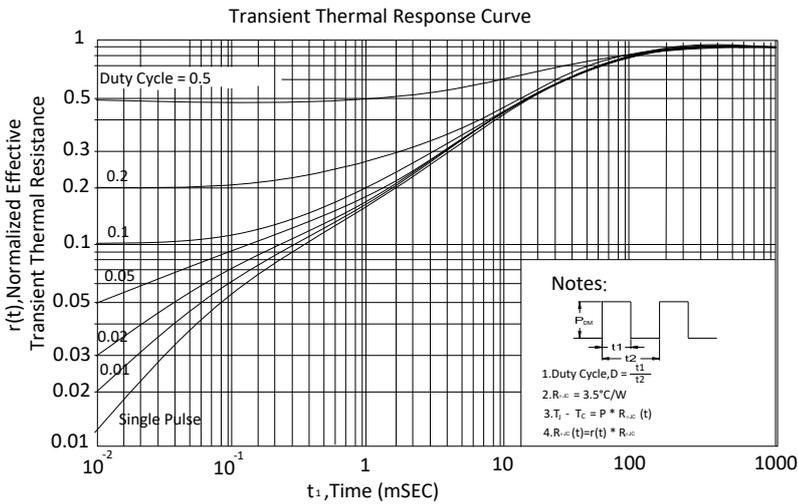
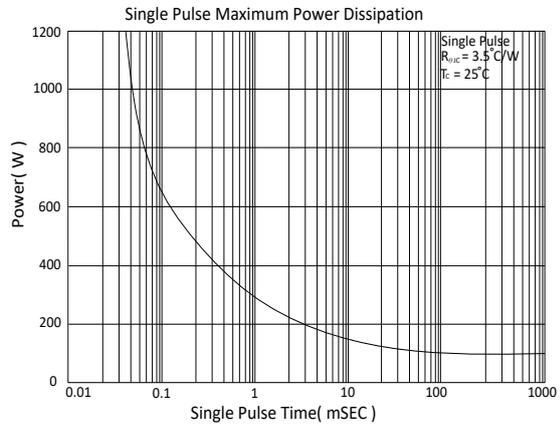
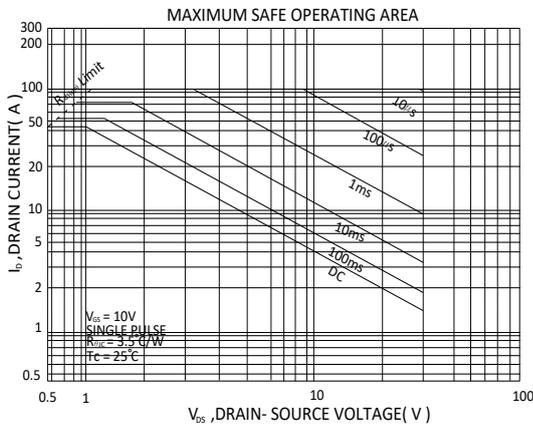
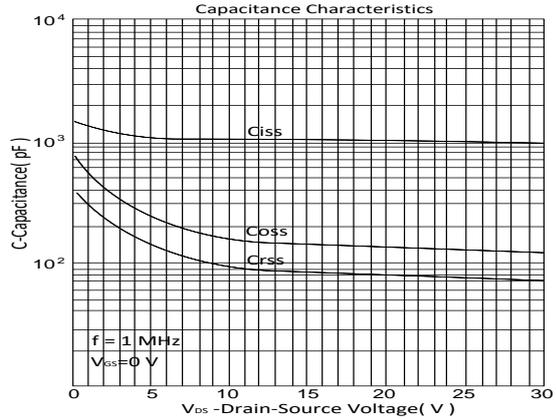
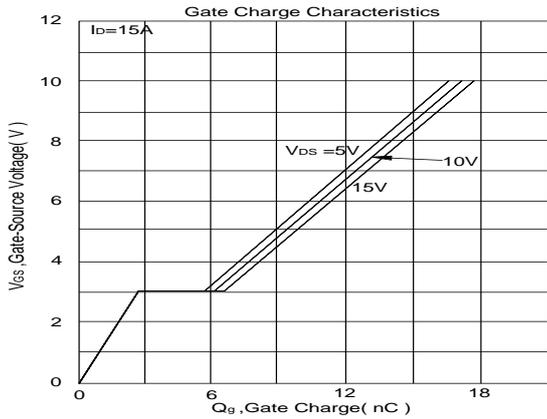
C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

DEFG: Serial No.



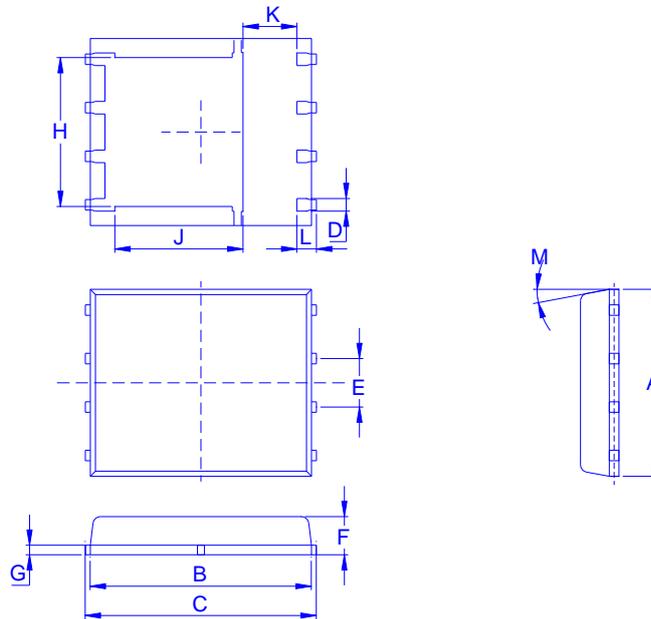
TYPICAL CHARACTERISTICS







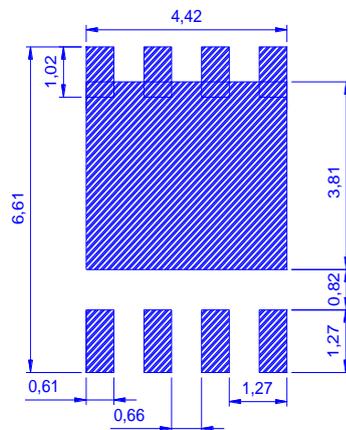
Outline Drawing



Dimension in mm

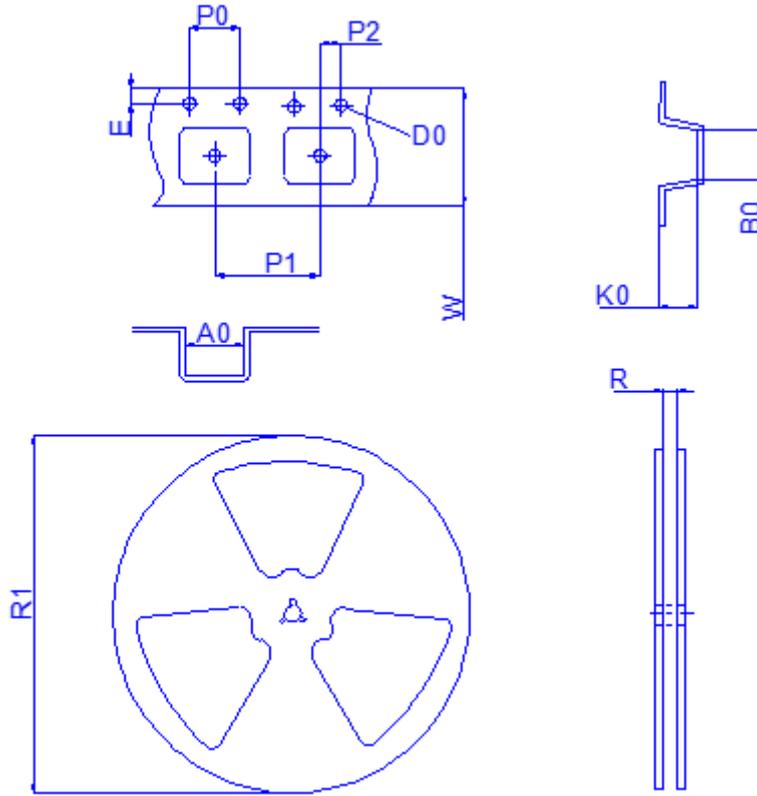
| Dimension | A | B | C | D | E | F | G | H | J | K | L | M |
|-----------|-----|------|------|------|------|------|------|------|------|------|------|-----|
| Min | 4.8 | 5.55 | 5.9 | 0.3 | 1.17 | 0.85 | 0.15 | 3.61 | 3.18 | 1 | 0.38 | 0° |
| Typ. | 4.9 | 5.7 | 6 | 0.4 | 1.27 | 0.95 | 0.2 | 3.87 | 3.44 | 1.2 | 0.4 | |
| Max | 5.4 | 5.85 | 6.15 | 0.51 | 1.37 | 1.17 | 0.34 | 4.31 | 3.78 | 1.39 | 0.71 | 12° |

Recommended minimum pads





Tape&Reel Information:2500pcs/Reel



| | |
|--------------------|--------------------------------|
| Package | EDFN5X6 |
| Reel | 13" |
| Device orientation | <p>FEED DIRECTION</p> <p>→</p> |

Dimension in mm

| Dimension | Carrier tape | | | | | | | | | Reel | |
|-----------|--------------|-----|-----|-----|-----|-----|-----|-----|-----|------|-----|
| | A0 | B0 | D0 | E | K0 | P0 | P1 | P2 | W | R | R1 |
| Typ. | 6.4 | 5.3 | 1.5 | 1.8 | 1.6 | 4 | 8 | 2 | 12 | 12.4 | 330 |
| ± | 0.2 | 0.2 | 0.1 | 0.1 | 0.6 | 0.1 | 0.1 | 0.1 | 0.3 | 2 | 2 |